

-N-type Technology HOT 3.0

-Technology N-type

-modules with Tunnel Oxide Passivation Contacts (Topcon) technology offer lower LID/LeTID degradation and better low light performance.

-Dual-Sided Power Generation N-type modules with HOT 3.0 technology offer battery reliability and efficiency..

Mechanical Load Enhanced 100% 99%.

12Year Product Warranty.

30Year Linear Power Warranty 87.4% 2 1% 30 0.40% First-year Degradation Annual Degradation Over 30 Years ·

IEC61215:2021 / IEC61730:2023 ·IEC61701 / IEC62716 / IEC60068 / IEC62804 Dual-sided

power generation gain increases with backside exposure to light, significantly reducing LCOE.

SMBB Technology Better light trapping and current collection to improve module power output and reliability.

Certified to withstand: 5400 Pa front side max static test load 2400 Pa rear side max static test load Anti-PID Guarantee Minimizes the chance of degradation caused by PID phenomena through optimization of cell production technology and material control. ·